

April 1988 Revised March 2000

#### 74F194

# 4-Bit Bidirectional Universal Shift Register

#### **General Description**

The 74F194 is a high-speed 4-bit bidirectional universal shift register. As a high-speed, multifunctional, sequential building block, it is useful in a wide variety of applications. It may be used in serial-serial, shift left, shift right, serial-parallel, parallel-serial, and parallel-parallel data register transfers.

#### **Features**

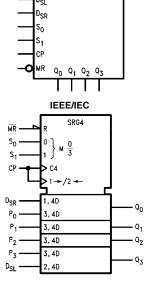
- Typical shift frequency of 150 MHz
- Asynchronous master reset
- Hold (do nothing) mode
- Fully synchronous serial or parallel data transfers

#### **Ordering Code:**

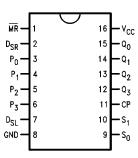
Order Number	Package Number	Package Description
74F194SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
74F194SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F194PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### **Logic Symbols**



#### **Connection Diagram**



### **Unit Loading/Fan Out**

Pin Names	Description	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>	
Fill Names	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>	
S <sub>0</sub> , S <sub>1</sub>	Mode Control Inputs	1.0/1.0	20 μA/-0.6 mA	
P <sub>0</sub> -P <sub>3</sub>	Parallel Data Inputs	1.0/1.0	20 μA/-0.6 mA	
D <sub>SR</sub>	Serial Data Input (Shift Right)	1.0/1.0	20 μA/-0.6 mA	
D <sub>SL</sub>	Serial Data Input (Shift Left)	1.0/1.0	20 μA/-0.6 mA	
CP	Clock Pulse Input (Active Rising Edge)	1.0/1.0	20 μA/-0.6 mA	
MR	Asynchronous Master Reset Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA	
$Q_0-Q_3$	Parallel Outputs	50/33.3	−1 mA/20 mA	

#### **Functional Description**

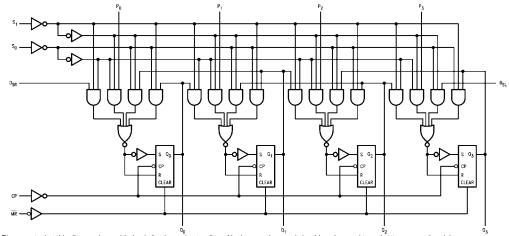
The 74F194 contains four edge-triggered D-type flip-flops and the necessary interstage logic to synchronously perform shift right, shift left, parallel load and hold operations. Signals applied to the Select  $(S_0,\,S_1)$  inputs determine the type of operation, as shown in the Mode Select Table. Signals on the Select, Parallel data  $(P_0-P_3)$  and Serial data  $(D_{SR},\,D_{SL})$  inputs can change when the clock is in either state, provided only that the recommended setup and hold times, with respect to the clock rising edge, are observed. A LOW signal on Master Reset  $(\overline{MR})$  overrides all other inputs and forces the outputs LOW.

#### **Mode Select Table**

Operating	Inputs							Outputs			
Mode	MR	S <sub>1</sub>	S <sub>0</sub>	D <sub>SR</sub>	$D_{SL}$	$\mathbf{P}_{\mathbf{n}}$	$Q_0$	$Q_1$	$Q_2$	$Q_3$	
Reset	L	Χ	Χ	Х	Х	Х	L	L	L	L	
Hold	Н	ı	I	Х	Χ	Χ	$q_0$	$q_1$	$q_2$	$q_3$	
Shift Left	Н	h	I	Х	I	Х	$q_1$	$q_2$	$q_3$	L	
	Н	h	-1	Х	h	Х	$q_1$	$q_2$	$q_3$	Н	
Shift Right	Н	I	h	I	Χ	Х	L	$q_0$	$q_1$	$q_2$	
	Н	I	h	h	Χ	Х	Н	$q_0$	$q_1$	$q_2$	
Parallel Load	Н	h	h	Х	Х	p <sub>n</sub>	$p_0$	p <sub>1</sub>	$p_2$	$p_3$	

H (h) = HIGH Voltage Level

## **Logic Diagram**



L (I) = LOW Voltage Level

 $p_n\left(q_n\right)$  = Lower case letters indicate the state of the referenced input (or output) one setup time prior to the LOW-to-HIGH clock transition. X = Immaterial

#### **Absolute Maximum Ratings**(Note 1)

 $\begin{array}{ll} \mbox{Storage Temperature} & -65^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \mbox{Ambient Temperature under Bias} & -55^{\circ}\mbox{C to } +125^{\circ}\mbox{C} \\ \end{array}$ 

Junction Temperature under Bias -55°C to +150°C V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0V

Input Voltage (Note 2) -0.5V to +7.0V Input Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with  $V_{CC} = 0V$ )

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & -0.5 \text{V to } +5.5 \text{V} \end{array}$ 

Current Applied to Output

in LOW State (Max) twice the rated  $I_{OL}$  (mA)

# Recommended Operating Conditions

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

Symbol	Parameter		Min	Тур	Max	Units	v <sub>cc</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage				-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.5			V	Min	$I_{OH} = -1 \text{ mA}$
	Voltage	5% V <sub>CC</sub>	2.7			V	IVIII	$I_{OH} = -1 \text{ mA}$
V <sub>OL</sub>	Output LOW	10% V <sub>CC</sub>			0.5			J 20 A
	Voltage				0.5			I <sub>OL</sub> = 20 mA
I <sub>IH</sub>	Input HIGH				5.0			V 0.7V
	Current				5.0	μА	Max	$V_{IN} = 2.7V$
I <sub>BVI</sub>	Input HIGH Current				7.0	^	May	V 7.0V
	Breakdown Test				7.0	μА	iviax	V <sub>IN</sub> = 7.0V
I <sub>CEX</sub>	Output HIGH				50	μА	Mov	V - V
	Leakage Current				30	μΑ	IVIAX	$V_{OUT} = V_{CC}$
V <sub>ID</sub>	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9 \mu A$
	Test		4.75			V	0.0	All Other Pins Grounded
I <sub>OD</sub>	Output Leakage				0.75	^	0.0	V <sub>IOD</sub> = 150 mV
	Circuit Current				3.75	μА	0.0	All Other Pins Grounded
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	V <sub>IN</sub> = 0.5V
los	Output Short-Circuit Current		-60		-150	mA	Max	V <sub>OUT</sub> = 0V
Icc	Power Supply Current			33	46	mA	Max	

# **AC Electrical Characteristics**

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF		Units
		Min	Тур	Max	Min	Max	Min	Max	
f <sub>MAX</sub>	Maximum Shift Frequency	105	150		90		90		MHz
t <sub>PLH</sub>	Propagation Delay	3.5	5.2	7.0	3.0	8.5	3.5	8.0	20
t <sub>PHL</sub>	CP to Q <sub>n</sub>	3.5	5.5	7.0	3.0	8.5	3.5	8.0	ns
t <sub>PHL</sub>	Propagation Delay  MR to Q <sub>n</sub>	4.5	8.6	12.0	4.5	14.5	4.5	14.0	ns

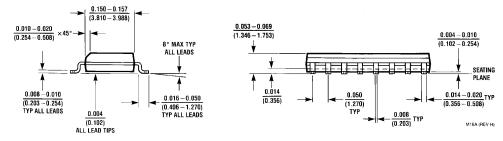
# **AC Operating Requirements**

Symbol	Parameter		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = -55^{\circ}C$ to $+125^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$	
		Min	Max	Min	Max	Min	Max	
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	4.0		6.0		4.0		
t <sub>S</sub> (L)	P <sub>n</sub> or D <sub>SR</sub> or D <sub>SL</sub> to CP	4.0		4.0		4.0		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	1.0		1.5		1.0		115
$t_H(L)$	P <sub>n</sub> or D <sub>SR</sub> or D <sub>SL</sub> to CP	0		1.0		1.0		
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	10.0		10.5		11.0		
$t_S(L)$	S <sub>n</sub> to CP	8.0		8.0		8.0		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	0		0		0		115
$t_H(L)$	S <sub>n</sub> to CP	0		0		0		
t <sub>W</sub> (H)	CP Pulse Width, HIGH	5.0		5.5		5.5		ns
t <sub>W</sub> (L)	MR Pulse Width, LOW	5.0		5.0		5.0		ns
t <sub>REC</sub>	Recovery Time MR to CP	9.0		9.0		11.0		ns

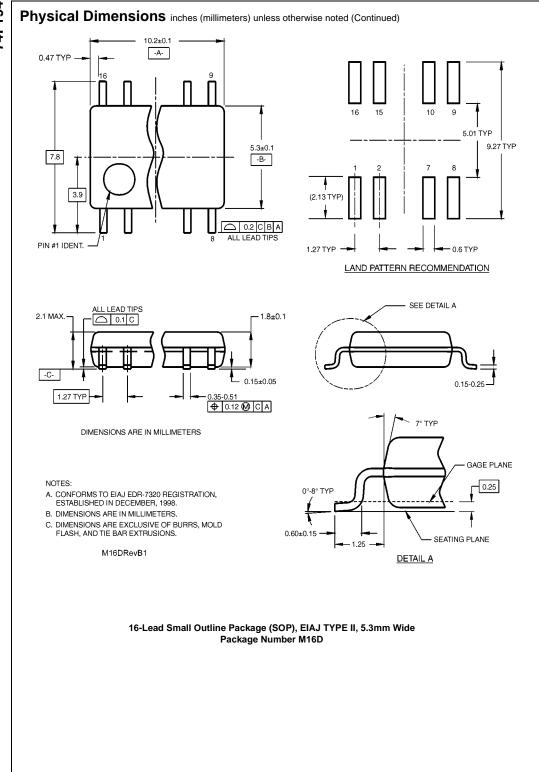
0.010 (0.254) MAX

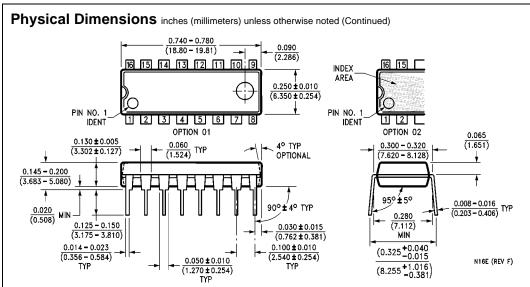
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LEAD NO.1



16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow Package Number M16A





16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

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